



33082M298

PATENT

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Tsuneyuki Okabe, et al.

U.S. Serial No.: 10/564,558

Group Art Unit: To Be Assigned

Filed: : January 13, 2006

Examiner: To Be Assigned

For: SEMICONDUCTOR MANUFACTURING APPARATUS AND  
SEMICONDUCTOR MANUFACTURING METHOD

**SECOND INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure under 37 C.F.R. 1.56, Applicants are enclosing an Information Disclosure Citation Form (PTO-1449) and a copy of the documents cited therein. The two Japanese documents were cited and discussed on pages 3 and 4 of Applicants' specification.

It is respectfully requested that the cited documents be considered by the Examiner in the above-identified patent application and that the cited documents be made officially of record therein. It is further requested that a listing of the same appear on the face of any patent which may issue from this application.

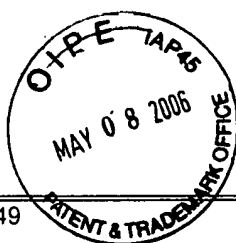
This Information Disclosure Statement is being filed before receipt of the initial Office Action in the present application, and therefore it is believed that no fees are due under 37 C.F.R. Section 1.97(i).

Respectfully submitted,  
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FORM PTO-1449 <b>INFORMATION DISCLOSURE STATEMENT</b>	ATTY. DOCKET <b>033082M298</b>	SERIAL NO. <b>10/564,558</b>
	APPLICANT: <b>Tsuneyuki OKABE, et al.</b>	
	FILING DATE <b>January 13, 2006</b>	GROUP ART UNIT <b>To Be Assigned</b>

#### U.S. PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE, IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

#### FOREIGN PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
							YES	NO
	AH	07-263350	10/13/95	Japan			Abstract	
	AI	05-289751	11/5/93	Japan			Abstract	
	AJ							
	AK							
	AL							
	AM							
	AN							
	AO							
	AP							

#### OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

	AQ	
	AR	
	AS	

EXAMINER:	DATE CONSIDERED:
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.